

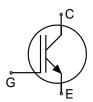
IGBT3 Power Chip

Features:

- 1200V Trench & Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- power modules
- **Applications:**
- drives



Chip Type	V _{CE}	I _C	Die Size	Package
SIGC20T120LE	1200V	15A	4.41 x 4.47 mm ²	sawn on foil

Mechanical Parameters

	·			
Raster size	4.41 x 4.47			
Emitter pad size	2.901 x 2.995	- mm ²		
Gate pad size	1.107 x 0.702	mm		
Area total	19.71			
Thickness	120	μm		
Wafer size	200	mm		
Max.possible chips per wafer	1381			
Passivation frontside	Photoimide			
Pad metal	3200 nm AlSiCu			
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	Electrically conductive glue or solder			
Wire bond	Al, <500µm			
Reject ink dot size	Ø 0.65mm ; max 1.2mm			
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C			



Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, T _{vj} =25 °C	V _{CE}	1200	V	
DC collector current, limited by $T_{vj max}$	I _C	1)	А	
Pulsed collector current, t_p limited by $T_{vj max}$	I _{c,puls}	45	А	
Gate emitter voltage	V _{GE}	±20	V	
Junction temperature range	T _{vj}	-55 +175	°C	
Operating junction temperature	T _{vj}	-55+150	°C	
Short circuit data ²⁾ V_{GE} = 15V, V_{CC} = 900V, T_{vj} = 125°C	t _{sc}	10	μs	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{C,max}$ = 30A, $V_{CE,max}$ = 1200V $T_{vj} \le 125^{\circ}C$			

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterization

Static Characteristic (tested on wafer), \mathcal{T}_{vj} =25 $^{\circ}C$

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V , <i>I</i> _C = 0.5mA	1200			
Collector-Emitter saturation voltage	V _{CEsat}	V _{GE} =15V, <i>I</i> _C =15A	1.4	1.7	2.1	V
Gate-Emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =0.6mA , $V_{\rm GE}$ = $V_{\rm CE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			2.16	μA
Gate-Emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			120	nA
Integrated gate resistor	r _G			none		Ω

Dynamic Characteristic (not subject to production test - verified by design / characterization), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			l Init
Falameter	Symbol	Conditions	min.	typ.	max.	Unit
Input capacitance	Cies	$V_{CE}=25V,$		1100		~ -
Reverse transfer capacitance	Cres	V _{GE} =0V, <i>f</i> =1MHz		50		- pF

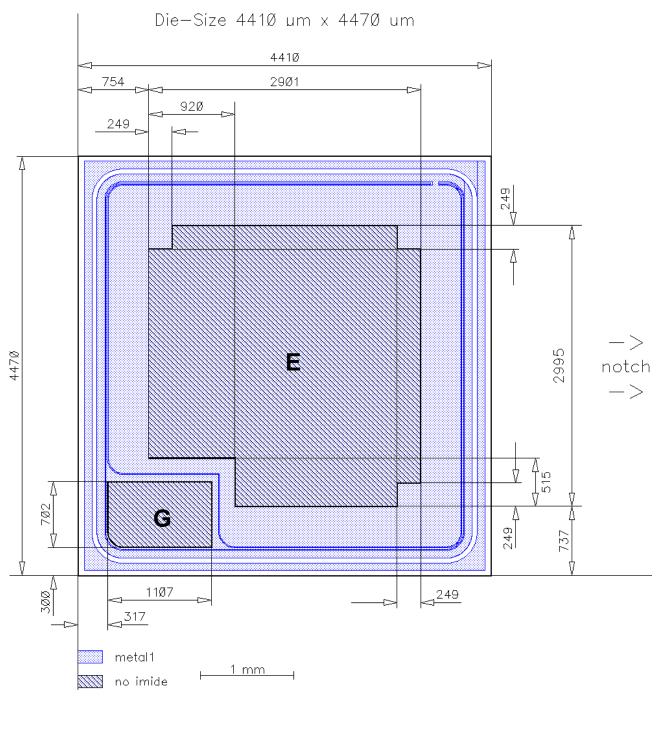


Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



Chip Drawing



E = Emitter

G = Gate

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Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date	
2.0	Release of final datasheet, change wafer size to 200 mm	30.04.2010	
2.1	Additional basic types L7631N, L7631U, L7631F	27.06.2014	

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